

Notice of References Cited

Application/Control No.

09/936,931

Applicant(s)/Patent Under
Reexamination
SCHUERING, INGO

Examiner

Heba Elkassabgi

Art Unit

2834

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,543,506	09-1985	Kawada et al.	310/156.59
	B	US-4,242,610	12-1980	McCarty et al.	310/156.59
	C	US-4,480,207 ✓	10-1984	Miller et al.	310/156.52
	D	US-4,578,610	03-1986	Kliman et al.	310/156.35
	E	US-4,918,346	04-1990	Tajima et al.	310/156.43
	F	US-4,631,807	12-1986	Kawada et al.	29/598
	G	US-4,167,692 ✓	09-1979	Sekiya et al.	318/138
	H	US-5,668,424 ✓	09-1997	Lamb, Karl Jerome	310/103
	I	US-5,010,266 ✓	04-1991	Uchida, Hiroyuki	310/156.22
	J	US-5,604,390 ✓	02-1997	Ackermann, Bernd	310/156.55
	K	US-5,463,262 ✓	10-1995	Uchida, Hiroyuki	310/156.61
	L	US-5,162,686 ✓	11-1992	Royer, Laurent	310/156.59
	M	US-5,378,953 ✓	01-1995	Uchida et al.	310/156.59

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

09/936,931

Applicant(s)/Patent Under
Reexamination
SCHUERING, INGO

Examiner

Heba Elkassabgi

Art Unit

2834

Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,091,668 ✓	02-1992	Cuenot et al.	310/156.61
	B	US-5,497,040 ✓	03-1996	Sato, Hironobu	310/67R
	C	US-5,345,133 ✓	09-1994	Satake, Akiyoshi	310/266
	D	US-5,955,807 ✓	09-1999	Kajiura et al.	310/156.66
	E	US-5,731,647 ✓	03-1998	Schuller et al.	310/114
	F	US-5,672,926 ✓	09-1997	Brandes et al.	310/181
	G	US-5,757,091 ✓	05-1998	Sogabe et al.	310/12
	H	US-5,886,441 ✓	03-1999	Uchida et al.	310/156.57
	I	US-5,829,120 ✓	11-1998	Uchida et al.	29/598
	J	US-5,889,346 ✓	03-1999	Uchida et al.	310/156.57
	K	US-5,939,810 ✓	08-1999	Uchida et al.	310/156.57
	L	US-3,407,320 ✓	10-1968		310/87
	M	US-6,072,257 ✓	06-2000	Akemakou, Dokou Antoine	310/191

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

09/936,931

Applicant(s)/Patent Under

Reexamination
SCHUERING, INGO

Examiner

Heba Elkassabgi

Art Unit

2834

Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,271,613 ✓	08-2001	Akemakou et al.	310/181
	B	US-6,437,474 ✓	08-2002	Chu, Ming Tsong	310/156.53
	C	US-6,285,104 ✓	09-2001	Nashiki, Masayuki	310/184
	D	US-6,147,415 ✓	11-2000	Fukada, Mitsuhiro	290/55
	E	US-			310/87
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP0582721	05-1997	DE	Otte et al.	H02K001/27
	O	EP0195741	03-1986	DE	Leltgeb et al.	H02K029/00
	P	EP0784371	07-1996	JP	Billington et la.	H02K41/03
	Q	FR2578116-A1	08-1986	FR	Epars	H02K021/08
	R	JP05146103	06-1993	JP	Nagate et al.	H02K001/27
	S	JP05161325	06-1993	JP	Iwamatsu et al.	H02K021/14
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.